

### General Description

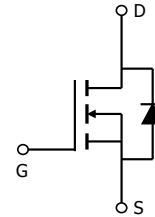
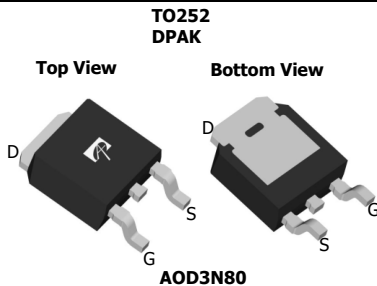
The AOD3N80 has been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.

By providing low  $R_{DS(on)}$ ,  $C_{iss}$  and  $C_{rss}$  along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.

### Product Summary

|                                 |            |
|---------------------------------|------------|
| $V_{DS}$                        | 900V@150°C |
| $I_D$ (at $V_{GS}=10V$ )        | 2.8A       |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ ) | < 4.8Ω     |

100% UIS Tested!  
 100%  $R_g$  Tested!



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter  | Symbol         | Maximum                 | Units |
|--|----------------|-------------------------|-------|
| Drain-Source Voltage   | $V_{DS}$       | 800                     | V     |
| Gate-Source Voltage  | $V_{GS}$       | $\pm 30$                | V     |
| Continuous Drain Current <sup>B</sup>  | $I_D$          | $T_C=25^\circ\text{C}$  | 2.8   |
|  |                | $T_C=100^\circ\text{C}$ | 1.8   |
| Pulsed Drain Current <sup>C</sup>  | $I_{DM}$       | 9                       | A     |
| Avalanche Current <sup>C</sup>   | $I_{AR}$       | 2.2                     | A     |
| Repetitive avalanche energy <sup>C</sup>                                     | $E_{AR}$       | 72                      | mJ    |
| Single pulsed avalanche energy <sup>H</sup>                                  | $E_{AS}$       | 145                     | mJ    |
| Peak diode recovery dv/dt  | dv/dt          | 5                       | V/ns  |
| Power Dissipation <sup>B</sup>   | $P_D$          | $T_C=25^\circ\text{C}$  | 83    |
|  |                | Derate above 25°C       | 0.7   |
| Junction and Storage Temperature Range                                       | $T_J, T_{STG}$ | -50 to 150              | °C    |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds | $T_L$          | 300                     | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typical | Maximum | Units |
|--|-----------------|---------|---------|-------|
| Maximum Junction-to-Ambient <sup>A,G</sup> | $R_{\theta JA}$ | 45      | 55      | °C/W  |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | -       | 0.5     | °C/W  |
| Maximum Junction-to-Case <sup>D,F</sup>    | $R_{\theta JC}$ | 1.2     | 1.5     | °C/W  |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

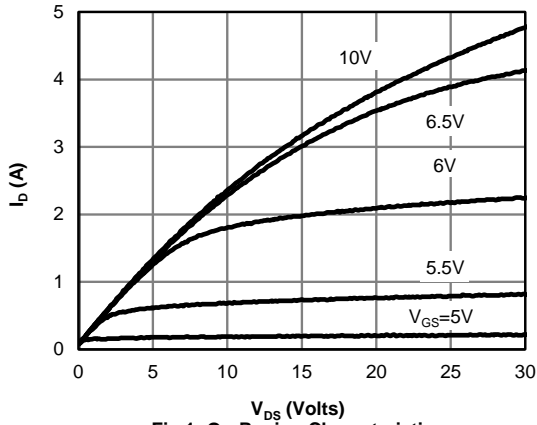
| Symbol                             | Parameter                             | Conditions  | Min | Typ  | Max  | Units |    |
|------------------------------------|---------------------------------------|---|-----|------|------|-------|----|
| <b>STATIC PARAMETERS</b>           |                                       |   |     |      |      |       |    |
| BV <sub>DSS</sub>                  | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                        | 800 |      |      | V     |    |
|                                    |                                       | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                       |     | 900  |      |       |    |
| BV <sub>DSS</sub> /ΔT <sub>J</sub> | Zero Gate Voltage Drain Current       | ID=250μA, VGS=0V  |     | 0.78 |      | V/°C  |    |
| I <sub>DSS</sub>                   | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =800V, V <sub>GS</sub> =0V  |     |      | 1    | μA    |    |
|                                    |                                       | V <sub>DS</sub> =640V, T <sub>J</sub> =125°C  |     |      | 10   |       |    |
| I <sub>GSS</sub>                   | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V  |     |      | ±100 | nA    |    |
| V <sub>GS(th)</sub>                | Gate Threshold Voltage                | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA  | 3.3 | 4.2  | 4.5  | V     |    |
| R <sub>DS(ON)</sub>                | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =1.5A  |     | 3.8  | 4.8  | Ω     |    |
| g <sub>FS</sub>                    | Forward Transconductance              | V <sub>DS</sub> =40V, I <sub>D</sub> =1.5A  |     | 2.5  |      | S     |    |
| V <sub>SD</sub>                    | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.77 | 1    | V     |    |
| I <sub>S</sub>                     | Maximum Body-Diode Continuous Current |   |     |      | 2.8  | A     |    |
| I <sub>SM</sub>                    | Maximum Body-Diode Pulsed Current     |   |     |      | 9    | A     |    |
| <b>DYNAMIC PARAMETERS</b>          |                                       |   |     |      |      |       |    |
| C <sub>iss</sub>                   | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz                                       |     | 510  |      | pF    |    |
| C <sub>oss</sub>                   | Output Capacitance                    |   |     |      | 39   |       | pF |
| C <sub>riss</sub>                  | Reverse Transfer Capacitance          |   |     |      | 3.7  |       | pF |
| R <sub>g</sub>                     | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |     | 2.9  |      | Ω     |    |
| <b>SWITCHING PARAMETERS</b>        |                                       |   |     |      |      |       |    |
| Q <sub>g</sub>                     | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =640V, I <sub>D</sub> =3A                         |     | 10   |      | nC    |    |
| Q <sub>gs</sub>                    | Gate Source Charge                    |   |     | 2.6  |      | nC    |    |
| Q <sub>gd</sub>                    | Gate Drain Charge                     |   |     | 2.9  |      | nC    |    |
| t <sub>D(on)</sub>                 | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =3A,<br>R <sub>G</sub> =25Ω |     | 21   |      | ns    |    |
| t <sub>r</sub>                     | Turn-On Rise Time                     |   |     | 25   |      | ns    |    |
| t <sub>D(off)</sub>                | Turn-Off DelayTime                    |   |     | 34   |      | ns    |    |
| t <sub>f</sub>                     | Turn-Off Fall Time                    |   |     | 19   |      | ns    |    |
| t <sub>rr</sub>                    | Body Diode Reverse Recovery Time      | I <sub>F</sub> =3A, di/dt=100A/μs, V <sub>DS</sub> =100V                                |     | 344  |      | ns    |    |
| Q <sub>rr</sub>                    | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =3A, di/dt=100A/μs, V <sub>DS</sub> =100V                                |     | 2.2  |      | μC    |    |

- A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25° C.
- B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C in a TO252 package, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.
- D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C.
- G. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.
- H. L=60mH, I<sub>AS</sub>=2.2A, V<sub>DD</sub>=150V, R<sub>G</sub>=10Ω, Starting T<sub>J</sub>=25° C

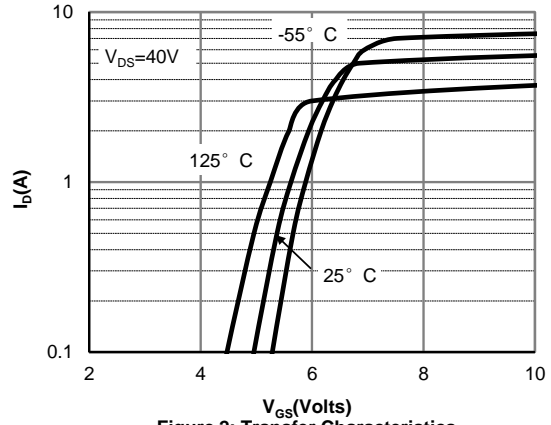
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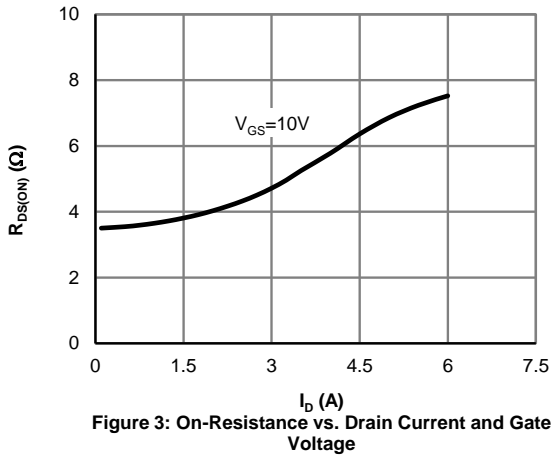
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



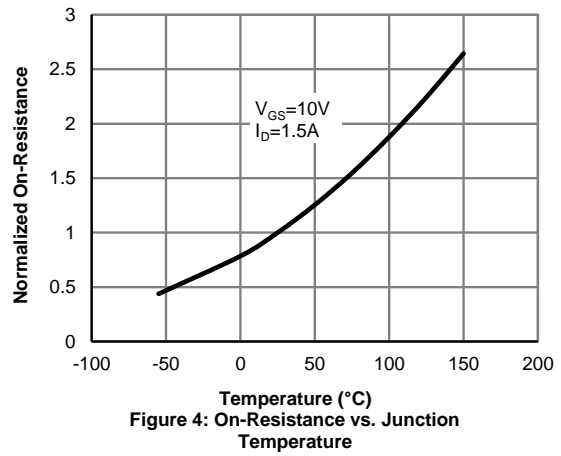
**Fig 1: On-Region Characteristics**



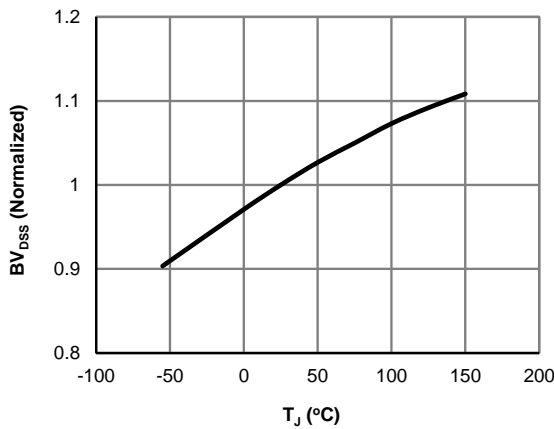
**Figure 2: Transfer Characteristics**



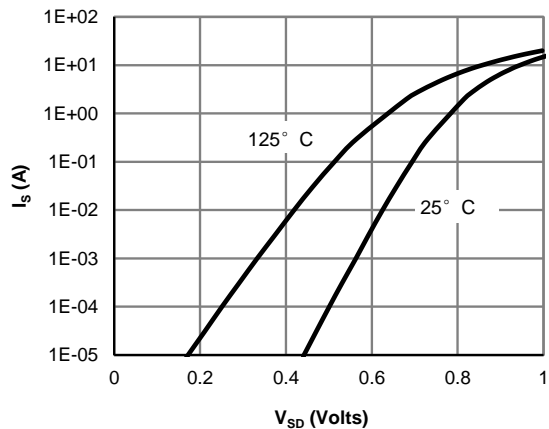
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage**



**Figure 4: On-Resistance vs. Junction Temperature**

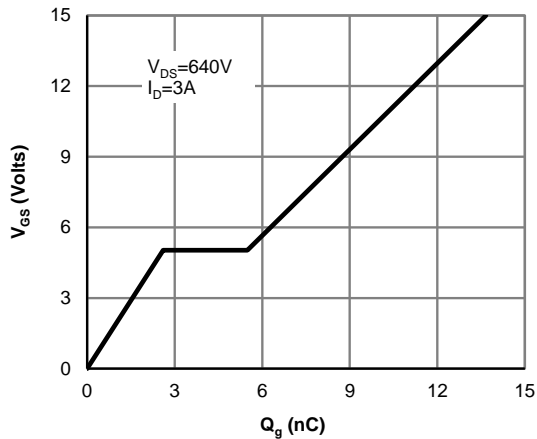


**Figure 5: Break Down vs. Junction Temperature**

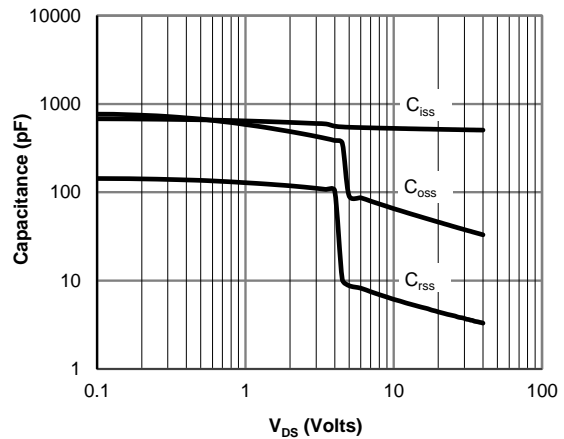


**Figure 6: Body-Diode Characteristics**

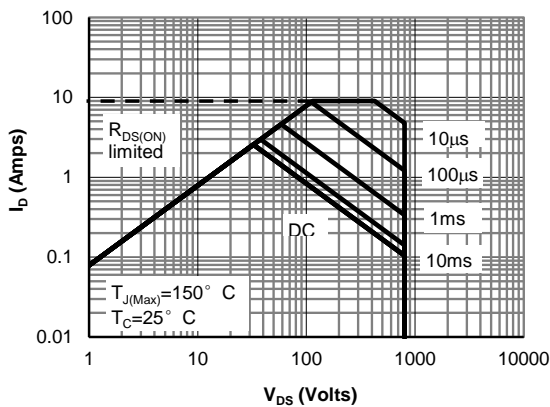
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



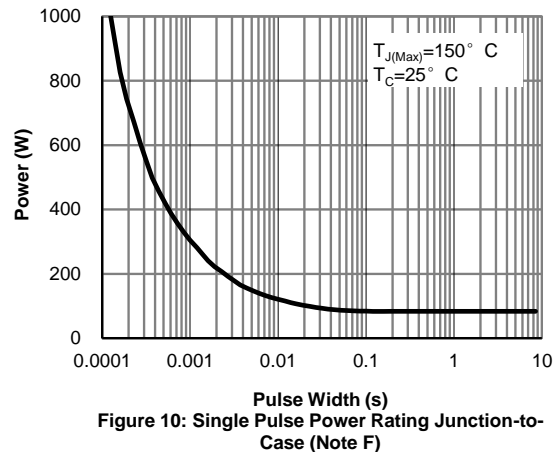
**Figure 7: Gate-Charge Characteristics**



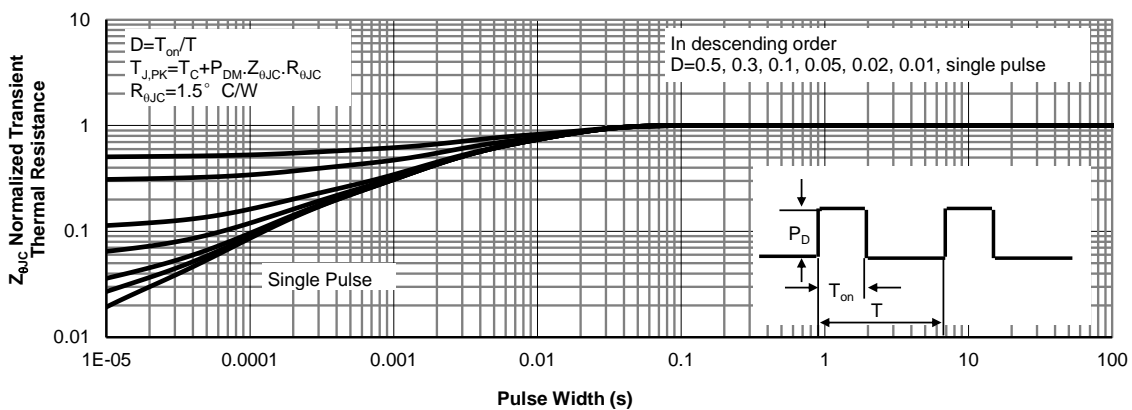
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

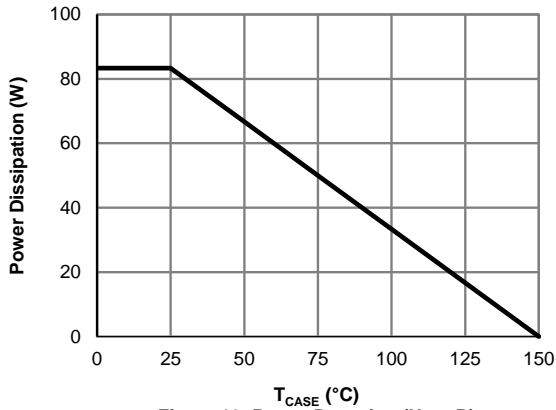


Figure 12: Power De-rating (Note B)

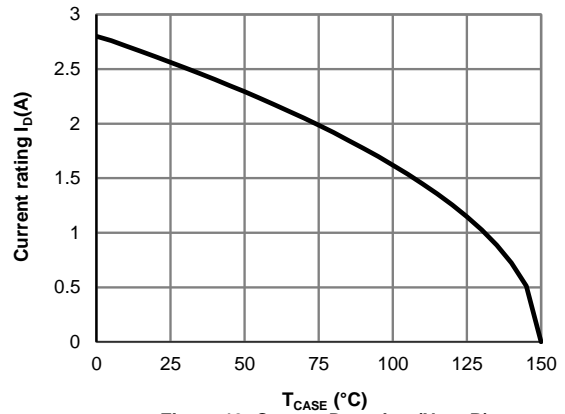


Figure 13: Current De-rating (Note B)

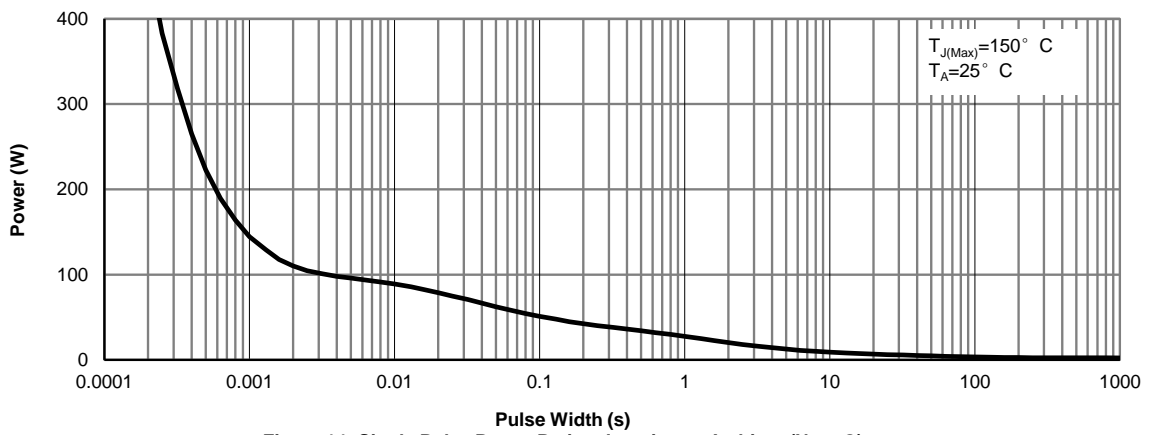


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note G)

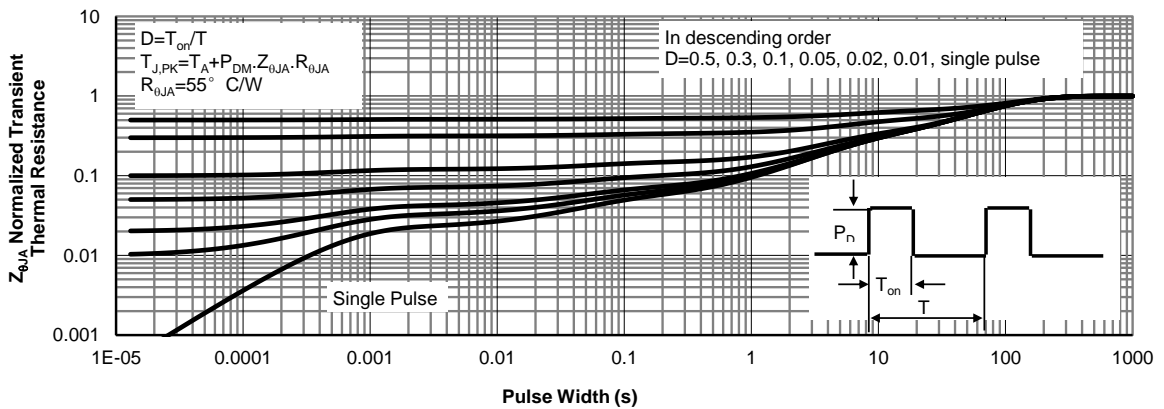
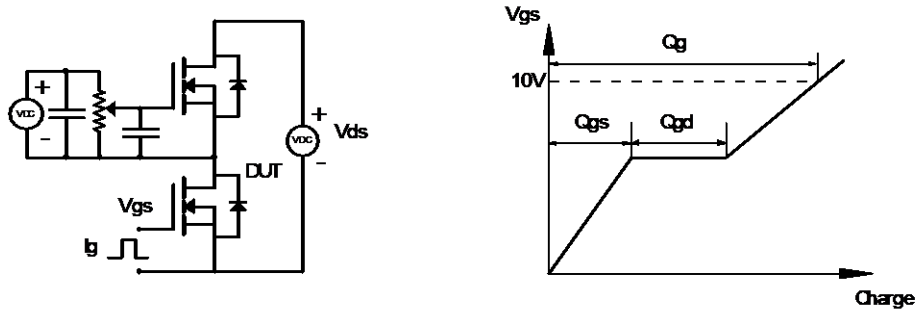
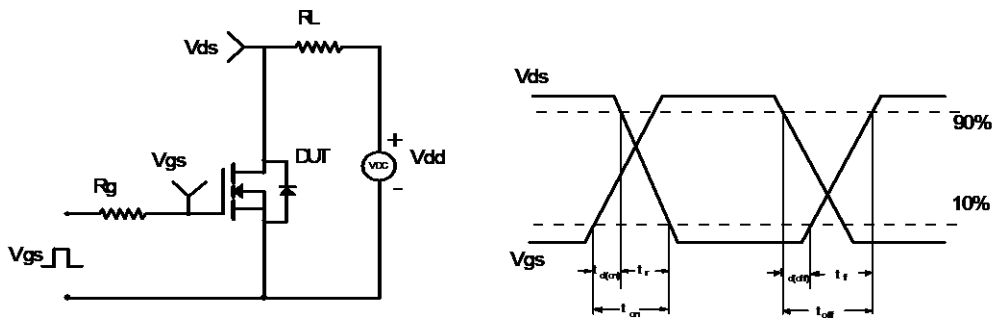


Figure 15: Normalized Maximum Transient Thermal Impedance (Note G)

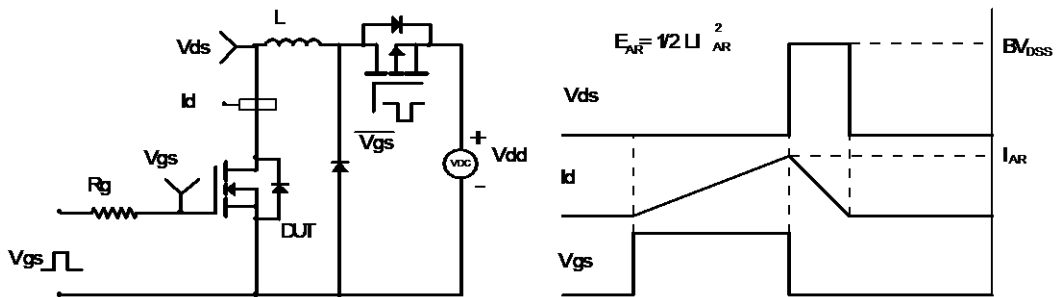
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

